TOSHIBA INSULATED GATE BIPOLAR TRANSISTOR SILICON N CHANNEL IGBT

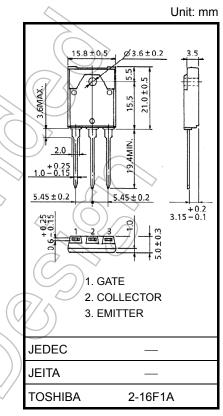
GT35J321

Fourth-generation IGBT Current Resonance Inverter Switching Applications

- Enhancement mode
- High speed: $t_f = 0.19 \ \mu s$ (typ.) (I_C = 50 A)
- Low saturation voltage: V_{CE} (sat) = 1.9 V (typ.) (I_C = 50 A)
- FRD included between emitter and collector
- Toshiba package name: TO-3P(N)IS

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	$\langle \rangle$
Collector-emitter voltage		V _{CES}	600	V	
Gate-emitter voltage		V _{GES}	±25	V	
Collector current (DC)	@ Tc = 100°C	ΙC	18	A	
	@ Tc = 25°C		37	✓ A	
Collector current (pulse)		I _{CP}	100	А	(
Diode forward current	DC	IF (20	A	
	Pulse	IFP	40		
Collector power dissipation	@ Tc = 100°C	Pc	30	≥	\checkmark
	@ Tc = 25°C		75	~	\sim
Junction temperature		$\left(\left(T_{j} \right) \right)$	150	°C	
Storage temperature range		T _{stg}	-55 to 150	ç	



Weight: 5.8 g (typ.)

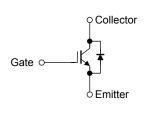
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

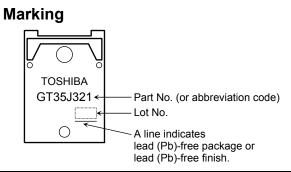
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Мах	Unit
Thermal resistance (IGBT)	Rth (j-c)	1.67	°C/W
Thermal resistance (diode)	Rth (j-c)	3.2	°C/W

Equivalent Circuit

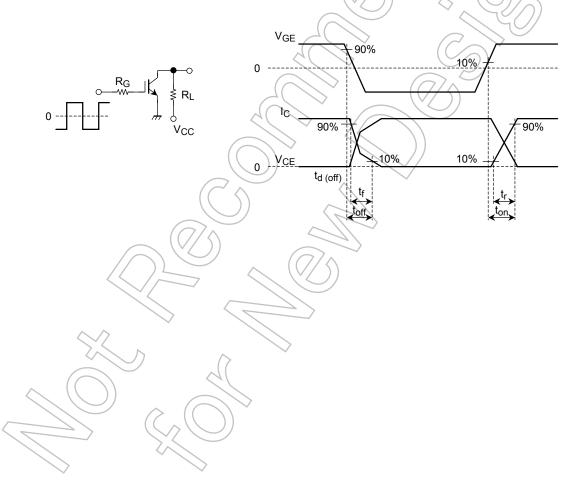




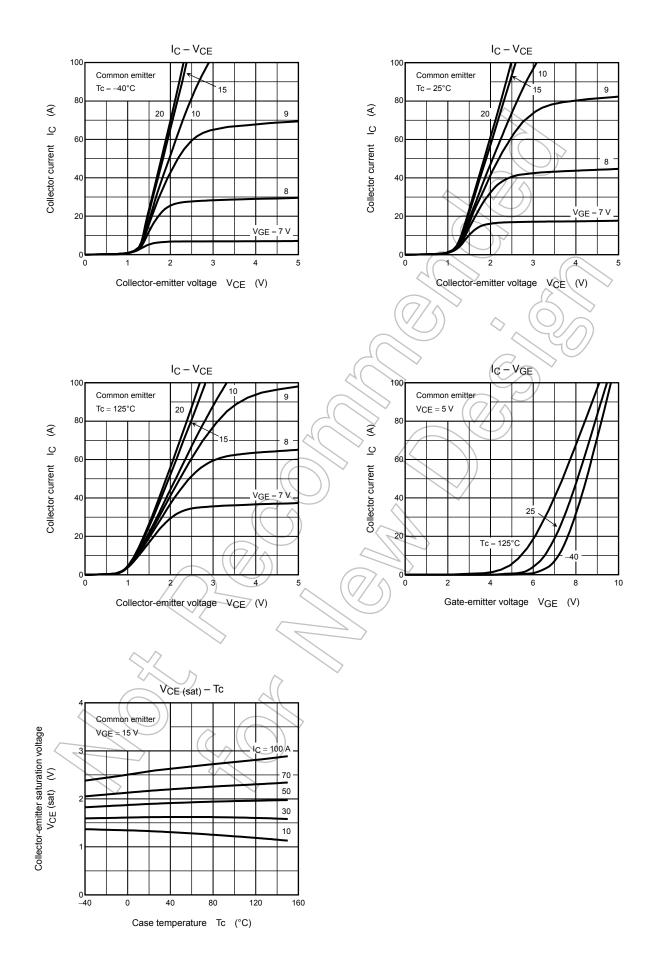
Electrical Characteristics (Ta = 25°C)

Char	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage curre	ent	I _{GES}	V_{GE} = ±25 V, V_{CE} = 0 V	—	_	±500	nA
Collector cut-off c	urrent	ICES	V _{CE} = 600 V, V _{GE} = 0 V	-	_	1.0	mA
Gate-emitter cut-o	ff voltage	V _{GE (OFF)}	I _C = 50 mA, V _{CE} = 5 V	3.0	_	6.0	V
Collector-emitter s	aturation voltage	V _{CE (sat)}	I _C = 50 A, V _{GE} = 15 V		1.9	2.3	V
Input capacitance		Cies	V _{CE} = 10 V, V _{GE} = 0 V, f = 1 MHz	(F	2500		pF
Switching time	Rise time	t _r	Resistive Load $V_{CC} = 300 \text{ V}, I_C = 50 \text{ A}$ $V_{GG} = \pm 15 \text{ V}, R_G = 39 \Omega$ (Note 1)		0.24		μs
	Turn-on time	t _{on}			0.33		
	Fall time	t _f			0.19	0.32	
	Turn-off time	t _{off}			0.51	_	
Diode forward voltage V _F		I _F = 15 A, V _{GE} = 0 V	_	\square	2.0	V	
Reverse recovery time t		t _{rr}	I _F = 15 A, di / dt = −100 A / μs	_	À	0.2	μs

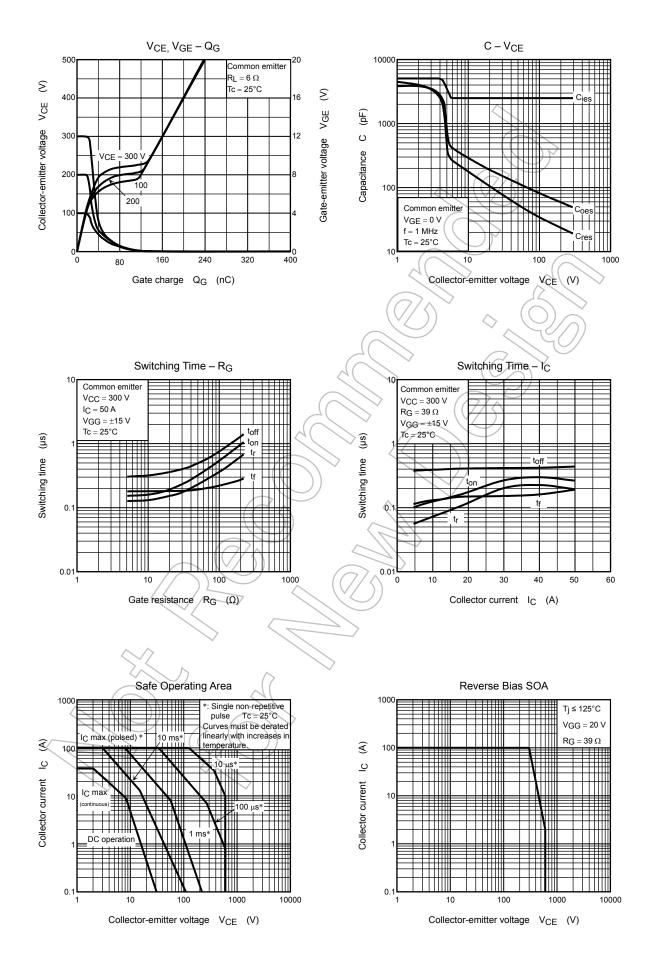
Note 1: Switching time measurement circuit and input/output waveforms

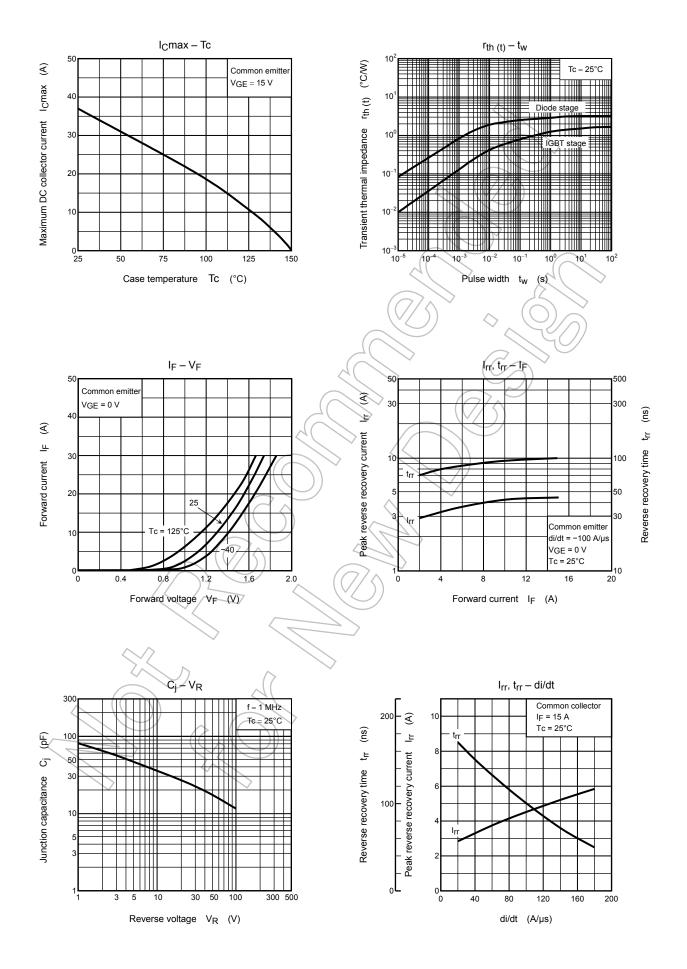


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Handbook" etc.

20070701-EN GENERAL

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